CORRECTION

Correction: Enhancing image resolution of confocal fluorescence microscopy with deep learning

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Following publication of this article [1], the statement in the Funding information section was incorrect and should have read:

The National Key R&D Program of China (2021YFF0502900); National Natural Science Foundation of China (61835009, 62127819, 61620106016, 62005171, 61975127); Natural Science Foundation of Guangdong Province (2020A1515010679); Key Project of Guangdong Provincial Department of Education (2021ZDZX2013); Shenzhen Science and Technology R&D and Innovation Foundation (JCYJ20220531102807017); Shenzhen International Cooperation Research Project (GJHZ20190822095420249).

The original article [1] has been corrected.

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Reference
1. Huang B, et al. Enhancing image resolution of confocal fluorescence microscopy with deep learning. PhotoniX. 2023;4:2.